

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re A	pplication of:)	T . NI 437 4 A		
TADAO ENDO		:)	Examiner: Not Yet Assigned		
Application No.: 10/829,257		;	Group Art Unit: 2878		
Filed: April 22, 2004		;)			
For:	RADIATION IMAGING APPARATUS, RADIATION IMAGING SYSTEM, AND RADIATION IMAGING METHOD) : :)	August 23, 2004		
Commi P.O. Bo	op Amendment ssioner for Patents ox 1450 dria, VA 22313-1450				

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed foreign documents are also enclosed.

The concise explanation of relevance for the non-English documents is provided in the English abstracts attached to those documents.

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicant's undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

Fritz Klantschi

Attorney for Applicant Registration No.: 50,333

FITZPATRICK, CELLA, HARPER & SCINTO 30 Rockefeller Plaza New York, New York 10112-3800 Facsimile: (212) 218-2200

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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMME	RCF	ATTY DOCKET NO. 03560.003445	APPLICATION NO. 10/829,257					
U.S. DEPARTMENT OF COMME PATENT AND TRADEMARK OF LIST OF REFERENCES CITED BY PP (Use several sheets if necessa	CICANT(S)	APPLICANT TADAO ENDO						
	AUG 2 4 2004 2	FILING DATE Apri 22, 2004		GROUP 2878				
U.S. PATENT DOCUMENTS								
*EXAMINER DOCUMENT NUMBER	TRADEMINATE DATE	NAME	CLASS	SUBCLASS	FILING DATE			
FOREIGN PATENT DOCUMENTS								
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT			
JP 2000-116637	04/25/00	Japan	A61B	6/00	Abstract			
JP 5-260382	10/08/93	Japan	H04N	5/325	Abstract			
JP 2-273873	11/08/90	Japan	G06F	15/62	Abstract			
JP 3-133276	06/06/91	Japan	H04N	5/325	Abstract			
JP 3-106343	05/02/91	Japan	A61B	6/00	Abstract			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)								
			-					
EXAMINER DATE CONSIDERED								

Sheet 1 of 1

Form #62

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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.